

Wuxi Unigroup Microelectronics CO.,LTD.

20V N-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

 V_{DS} 20V I_{D} (at V_{GS} =10V) 4A

 $R_{DS(ON)}$ (at V_{GS} =10V) < 23.2m Ω

 $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) < 27.5m Ω

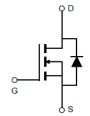
 $R_{DS(ON)}$ (at V_{GS} =2.5V) < 36.5m Ω

100% UIS Tested



SOT-23





Part Number	Package Type	Form	Marking
TTX2302	SOT-23	Tape&Reel	2302

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	±12	V
Continuous Drain Current B	T _C =25°C		4	۸
	T _C =70°C] I _D	3.2	Α
Pulsed Drain Current ^A		I _{DM}	12	Α
Avalanche Current ^A		I _{AS}	7	Α
Single Pulse Avalanche Energy L =0.3mH ^A		E _{AS}	7.4	mJ
Power Dissipation ^C	T _C =25°C	P _D	1	W
	T _C =70°C		0.64	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Maximum	Units		
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	14.4	00.004		
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	125	°C/W		



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Symbol	Parameter	Conditions		Value			11.24
Symbol	Parameter Conditions			Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V	T _J =25°C			1	μA
			T _J =100°C			25	
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 12V$	$V_{DS} = 0V, V_{GS} = \pm 12V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$		0.7	1.2	V
R _{DS(ON)} Static Drain-Source On-Re		V _{GS} =10V, I _D =2A			18.5	23.5	mΩ
	Static Drain-Source On-Resistance	V_{GS} =4.5V, I_D =2A			21.5	27.5	mΩ
		V _{GS} =2.5V, I _D =2A			28	36.5	mΩ
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =2A			7		S
V_{SD}	Diode Forward Voltage	I _S =2A, V _{GS} =0V				1	V
I _s	Maximum Body-Diode Continuous Cur	rent ^B			4	А	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	$V_{GS} = 0V, V_{DS} = 10V, f = 1MH_Z$			621		pF
C _{oss}	Output Capacitance				135		
C _{rss}	Reverse Transfer Capacitance				58		
SWITCHIN	NG PARAMETERS	·					
Q _g (10V)	Total Cata Charma	V _{GS} =10V,V _{DS} =10V, I _D =4A			12		nC
Q _g (4.5V)	─Total Gate Charge				5.8		
Q_{gs}	Gate Source Charge				0.7		
Q_gd	Gate Drain Charge				1.8		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 4A,$ $R_{G} = 2.5\Omega$			15		- ns
t _r	Turn-On Rise Time				17		
$T_{D(off)}$	Turn-Off Delay Time				42		
	Turn-Off Fall Time				40	1	

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

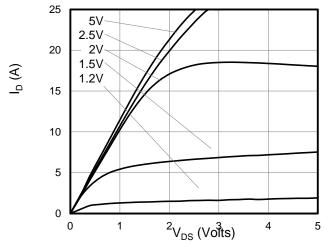


Figure 1: On-Region Characteristics

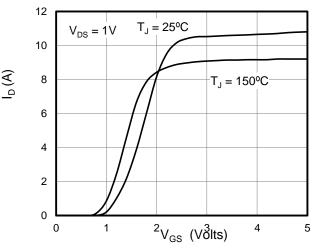


Figure 2: Transfer Characteristics

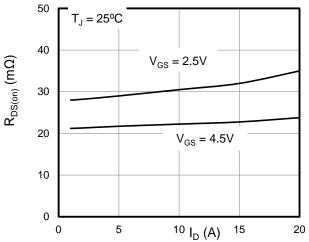


Figure 3: On-Resistance vs. Drain Current

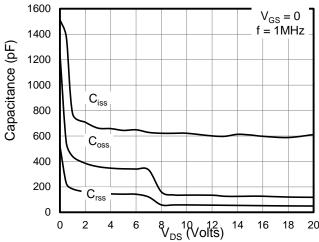


Figure 4: Capacitance Characteristics

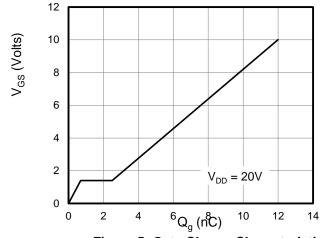


Figure 5: Gate Charge Characteristics

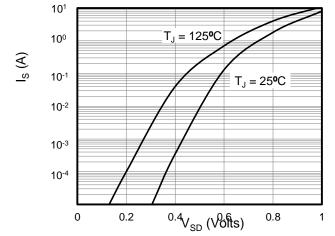
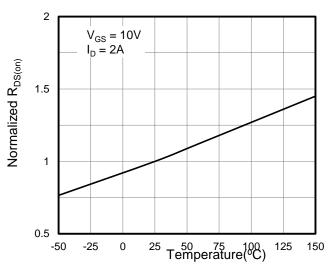


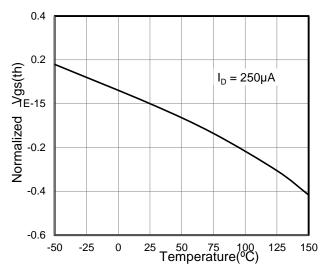
Figure 6: Body Diode Forward Voltage



 $Z_{\theta, JC}$ Normalized Transient Thermal Resistance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

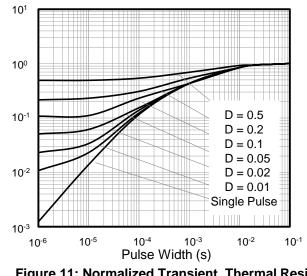




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Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



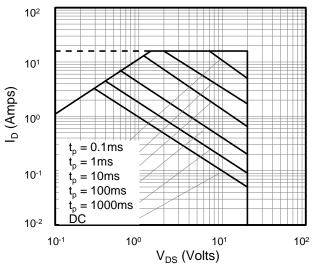


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area



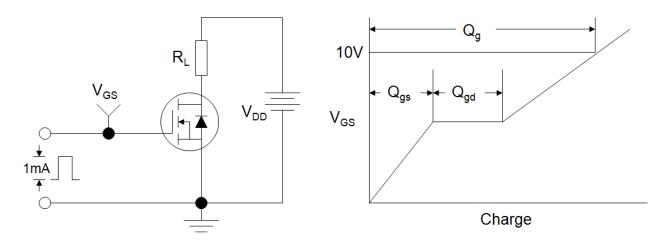


Figure A: Gate Charge Test Circuit and Waveforms

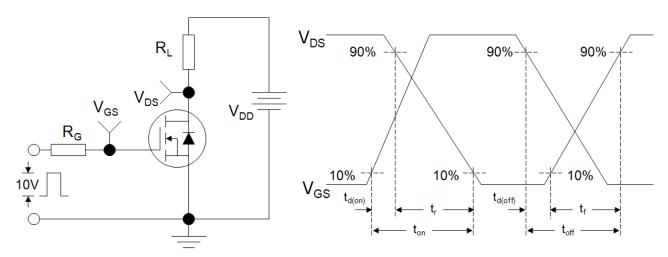


Figure B: Resistive Switching Test Circuit and Waveforms

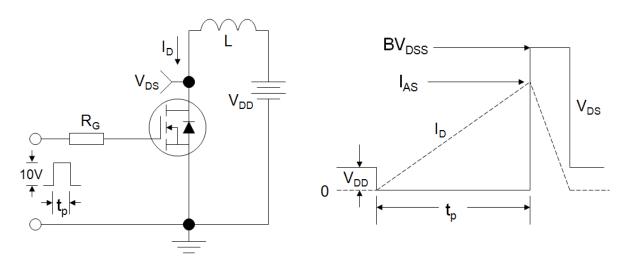
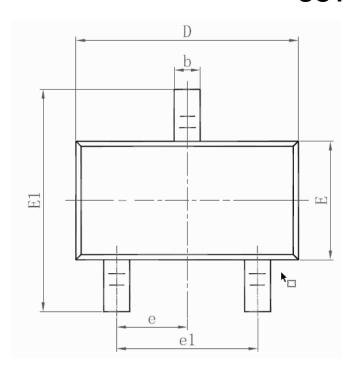
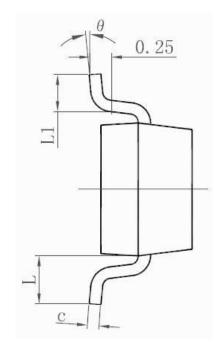


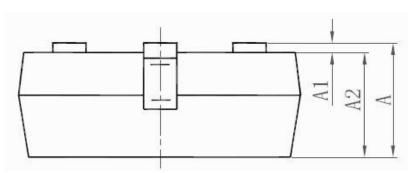
Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



SOT-23







Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
e	0.950	0.950 TYP.		TYP.	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF.		0.022 REF.		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	



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